

N-Channel MOSFET

General Description

The WSK30N20G is the highest performance trench N-Channel MOSFET with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The WSK30N20G meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

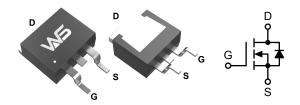
Product Summery

BV _{DSS}	R _{DSON}	I _D		
200V	57mΩ	40A		

Applications

- High Frequency Point-of-Load Synchronous Buck Converter
- Networking DC-DC Power System
- Load Switch

TO-263-2L Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	200	V
V_{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	40	Α
I _D @T _C =100℃	Continuous Drain Current, V _{GS} @ 10V ¹	28	Α
I _{DM}	Pulsed Drain Current ²	150	Α
EAS	Single Pulse Avalanche Energy ³	273	mJ
P _D	Total Power Dissipation ³	90	W
T _{STG}	Storage Temperature Range	-55 to 175	℃
T_J	Operating Junction Temperature Range	-55 to 175	°C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient ¹		62	°C/W
R _{θJC}	Thermal Resistance Junction-Case ¹		0.83	°C/W

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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	200			V	
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.098		V/°C	
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =15A		57	68	mΩ	
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	3.0	3.8	5.0	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS-VDS , IB -2500A		-4.57		mV/℃	
	Drain Source Leakage Current	V _{DS} =160V , V _{GS} =0V , T _J =25℃			1	uA	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =160V , V _{GS} =0V , T _J =55℃			5		
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 25V$, V_{DS} = $0V$			±1	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =15A		32		S	
Qg	Total Gate Charge (10V)			53			
Q _{gs}	Gate-Source Charge	V _{DS} =100V , V _{GS} =10V , I _D =15A		11		nC	
Q _{gd}	Gate-Drain Charge			15		1	
T _{d(on)}	Turn-On Delay Time			30			
Tr	Rise Time	V _{DD} =30V , V _{GS} =10V ,		20			
T _{d(off)}	Turn-Off Delay Time	$R_G=6\Omega$, $I_D=15A$, $R_L=30\Omega$		21		ns	
T _f	Fall Time			31			
C _{iss}	Input Capacitance			2445			
C _{oss}	Output Capacitance	V _{DS} =30V , V _{GS} =0V , f=1MHz		129		pF	
C _{rss}	Reverse Transfer Capacitance			24			

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I _S	Continuous Source Current ^{1,6}	V -V -0V Force Comment			36	Α
I _{SM}	Pulsed Source Current ^{2,6}	V _G =V _D =0V , Force Current			150	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =12A , T _J =25℃			1.3	V
t _{rr}	Reverse Recovery Time			48		nS
Q _{rr}	Reverse Recovery Charge	lF=12A , dl/dt=100A/μs , T _J =25℃		78		nC

Notes:

- $\textbf{1.} \ \textbf{Repetitive Rating: Pulse width limited by maximum junction temperature.}$
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300 μ s, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- **5.** EAS condition: Tj=25 $^{\circ}$ C,VDD=50V,VG=10V,L=0.5mH,Rg=25 Ω



Typical Characteristics

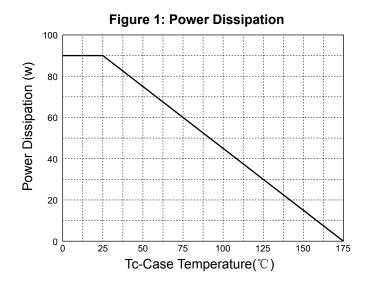


Figure 2: Drain Current

40

30

20

10

0

25

50

75

100

125

150

175

Tc-Case Temperature(°C)

Figure 3: Safe Operation Area

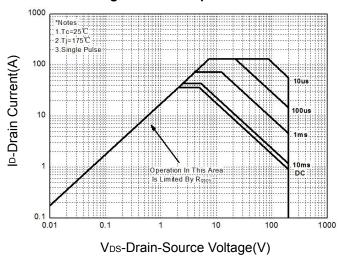
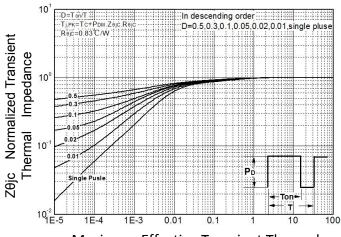
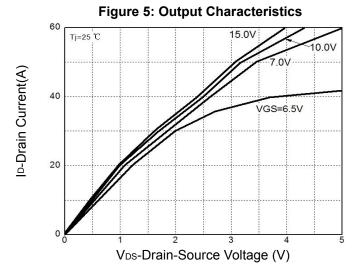
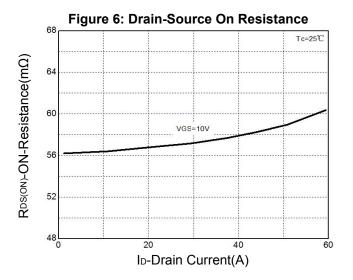


Figure 4: Thermal Transient Impedance



Maximum Effective Transient Thermal Impedance, Junction-to-Case







Typical Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

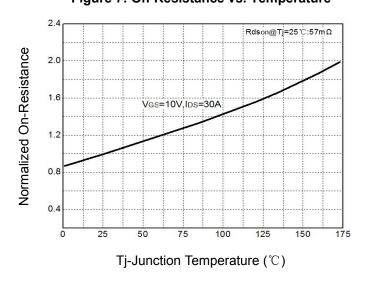


Figure 8: Source-Drain Diode Forward

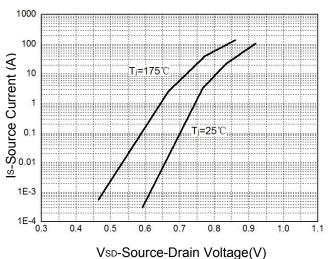


Figure 9: Capacitance Characteristics

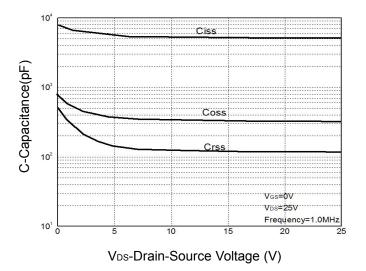
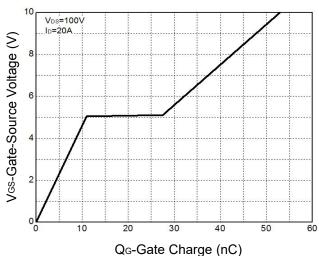
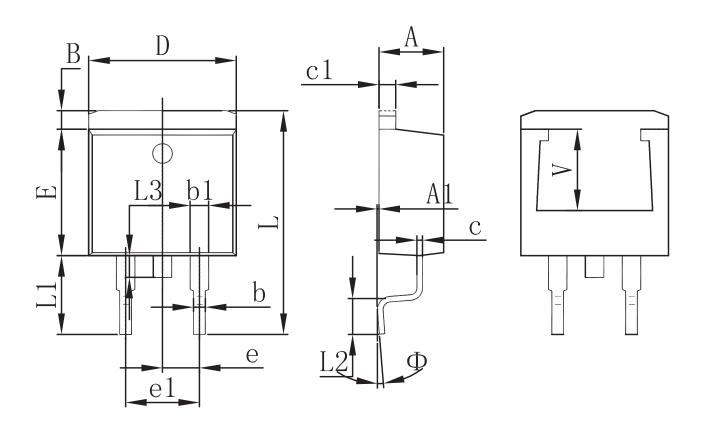


Figure 10: Gate Charge Characteristics





Packaging information



Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
Α	4.470	4.670	0.176	0.184	
A1	0.000	0.150	0.000	0.006	
В	1.120	1.420	0.044	0.056	
b	0.710	0.910	0.028	0.036	
b1	1.170	1.370	0.046	0.054	
С	0.310	0.530	0.012	0.021	
c1	1.170	1.370	0.046	0.054	
D	10.010	10.310	0.394	0.406	
E	8.500	8.900	0.335	0.350	
е	2.540 TYP.		0.100 TYP.		
e1	4.980	5.180	0.196	0.204	
L	14.940	15.500	0.588	0.610	
L1	4.950	5.450	0.195	0.215	
L2	2.340	2.740	0.092	0.108	
L3	1.300	1.700	0.051	0.067	
Ф	0°	8°	0°	8°	
V	5.600	5.600 REF. (REF.	



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